



Support & training



CSD13381F4

SLPS448F - JULY 2013 - REVISED JANUARY 2022

# CSD13381F4 12-V N-Channel FemtoFET<sup>™</sup> MOSFET

## 1 Features

- Low on-resistance
- Low Q<sub>q</sub> and Q<sub>qd</sub>
- Low threshold voltage
- Ultra-small footprint (0402 case size)
  1.0 mm × 0.6 mm
- Ultra-low profile
- Maximum height: 0.36-mm
- Integrated ESD protection diode
  - Rated > 4-kV HBM
  - Rated > 2-kV CDM
- Lead and halogen free
- RoHS compliant

## 2 Applications

- · Optimized for load switch applications
- Optimized for general purpose switching applications
- · Single-cell battery applications
- · Handheld and mobile applications

## **3 Description**

This 140-m $\Omega$ , 12-V N-channel FemtoFET<sup>IM</sup> MOSFET technology is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing at least a 60% reduction in footprint size.

#### **Product Summary**

T <sub>A</sub> = 25	°C	TYPICAL V	UNIT	
V <sub>DS</sub>	Drain-to-source voltage	12		V
Qg	Gate charge total (4.5 V)	1060		рС
Q <sub>gd</sub>	Gate charge gate-to-drain	140	рС	
		V <sub>GS</sub> = 1.8 V	310	mΩ
R <sub>DS(on)</sub>	Drain-to-source on-resistance	V <sub>GS</sub> = 2.5 V 170		mΩ
		V <sub>GS</sub> = 4.5 V	140	mΩ
V <sub>GS(th)</sub>	Threshold voltage	0.85		V

#### **Ordering Information**

· · · · · · · · · · · · · · · · · · ·										
DEVICE <sup>(1)</sup>	QTY	MEDIA	PACKGE	SHIP						
CSD13381F4	3000	7-inch	Femto (0402) 1.0-mm ×	Tape and						
CSD13381F4T	250	reel	0.6-mm SMD lead less	reel						

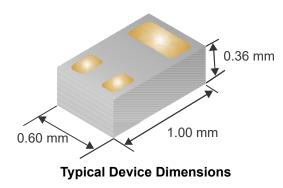
(1) For all available packages, see the orderable addendum at the end of the data sheet.

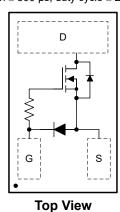
#### **Absolute Maximum Ratings**

T <sub>A</sub> = 25	°C unless otherwise stated	VALUE	UNIT	
V <sub>DS</sub>	Drain-to-source voltage	12	V	
V <sub>GS</sub>	Gate-to-source voltage	8	V	
ID	Continuous drain current, $T_A = 25^{\circ}C^{(1)}$	2.1	А	
I <sub>DM</sub>	Pulsed drain current, $T_A = 25^{\circ}C^{(2)}$	7	А	
1.	Continuous gate clamp current	35	mA	
IG	Pulsed gate clamp current <sup>(2)</sup>	350	ШA	
PD	Power dissipation <sup>(1)</sup>	500	mW	
ESD	Human body model (HBM)	4	kV	
Rating	Charged device model (CDM)	2	kV	
T <sub>J</sub> , T <sub>stg</sub>	Operating junction and storage temperature range	-55 to 150	°C	
E <sub>AS</sub>	Avalanche energy, single pulse I_D = 7.4 A, L = 0.1 mH, R_G = 25 $\Omega$	2.7	mJ	

(1) Typical  $R_{\theta JA} = 90^{\circ}$ C/W on 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>), 2 oz. (0.071 mm thick) Cu pad on a 0.06 inch (1.52 mm) thick FR4 PCB.

(2) Pulse duration  $\leq$  300 µs, duty cycle  $\leq$  2%





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#### **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision E (Octo	Page	
Changed Maximum height fro	m "0.35 mm" to "0.36 mm" in <i>Features</i>	1
· Changed package height from	n "0.35 mm" to "0.36 mm" in <i>Typical Device Dimensions</i>	1
Changed package height from	n "0.35 mm" to "0.36 mm" in <i>Mechanical Dimensions</i>	8
Changes from Revision D (May	2015) to Revision E (October 2021)	Page
Added footnote with link to su	pport document	9
Changes from Revision C (Sep	tember 2014) to Revision D (May 2015)	Page
Corrected typo for I <sub>GSS</sub> Test C	ondition	3



## **5** Specifications

### **5.1 Electrical Characteristics**

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS				I	
BV <sub>DSS</sub>	Drain-to-Source Voltage	V <sub>GS</sub> = 0 V, I <sub>DS</sub> = 250 μA	12			V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 9.6 V			100	nA
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 8 V			50	nA
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>DS</sub> = 250 μA	0.65	0.85	1.10	V
		V <sub>GS</sub> = 1.8 V, I <sub>DS</sub> = 0.5 A		310	400	mΩ
R <sub>DS(on)</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> = 2.5 V, I <sub>DS</sub> = 0.5 A		170	225	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>DS</sub> = 0.5 A		140	180	mΩ
9 <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 6 V, I <sub>DS</sub> = 0.5 A		3.2		S
	IC CHARACTERISTICS		·		1	
C <sub>iss</sub>	Input Capacitance			155	200	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0 V, V_{DS} = 6 V,$ f = 1 MHz		47	62	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	J = 1 10112		2.5	3.3	pF
R <sub>G</sub>	Series Gate Resistance			23		Ω
Qg	Gate Charge Total (4.5 V)			1060	1400	рС
Q <sub>gd</sub>	Gate Charge Gate-to-Drain			140		рС
Q <sub>gs</sub>	Gate Charge Gate-to-Source	V <sub>DS</sub> = 6 V, I <sub>DS</sub> = 0.5 A		230		рС
Q <sub>g(th)</sub>	Gate Charge at V <sub>th</sub>			155		рС
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 6 V, V <sub>GS</sub> = 0 V		1120		рС
t <sub>d(on)</sub>	Turn On Delay Time			3.7		ns
t <sub>r</sub>	Rise Time	$V_{DS} = 6 V, V_{GS} = 4.5 V,$		1.5		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$I_{DS} = 0.5 \text{ A}, R_G = 2 \Omega$		11.0		ns
t <sub>f</sub>	Fall Time			3.8		ns
DIODE C	CHARACTERISTICS				I	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 0.5 A, V <sub>GS</sub> = 0 V		0.73	0.9	V
Q <sub>rr</sub>	Reverse Recovery Charge			1550		рС
t <sub>rr</sub>	Reverse Recovery Time	V <sub>DS</sub> = 6 V, I <sub>F</sub> = 0.5 A, di/dt = 300 A/µs		6		ns

#### **5.2 Thermal Information**

(T<sub>A</sub> = 25°C unless otherwise stated)

	-	THERMAL METRIC	TYPICAL VALUES	UNIT
	R <sub>θJA</sub>	Junction-to-Ambient Thermal Resistance <sup>(1)</sup>	90	°C/W
		Junction-to-Ambient Thermal Resistance <sup>(2)</sup>	250	0/11

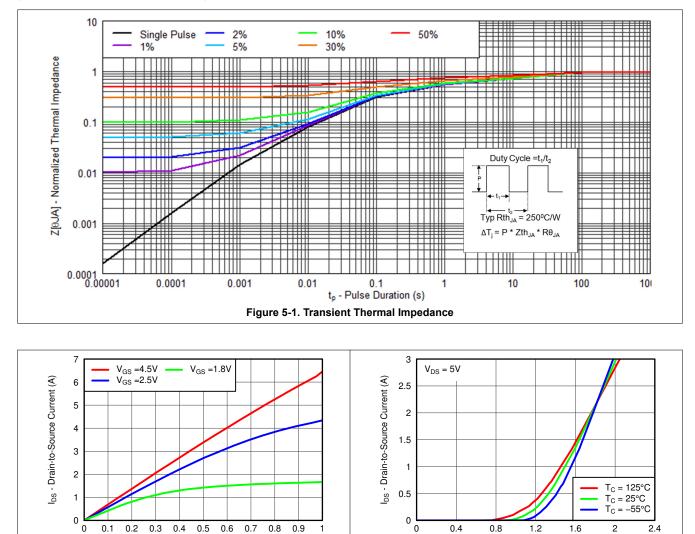
(1) Device mounted on FR4 material with 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>), 2 oz. (0.071 mm thick) Cu.

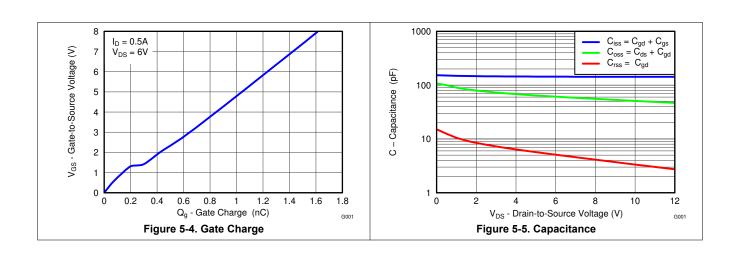
(2) Device mounted on FR4 material with minimum Cu mounting area.



### **5.3 Typical MOSFET Characteristics**

(T<sub>A</sub> = 25°C unless otherwise stated)





G001

V<sub>DS</sub> - Drain-to-Source Voltage (V)

Figure 5-2. Saturation Characteristics

V<sub>GS</sub> - Gate-to-Source Voltage (V)

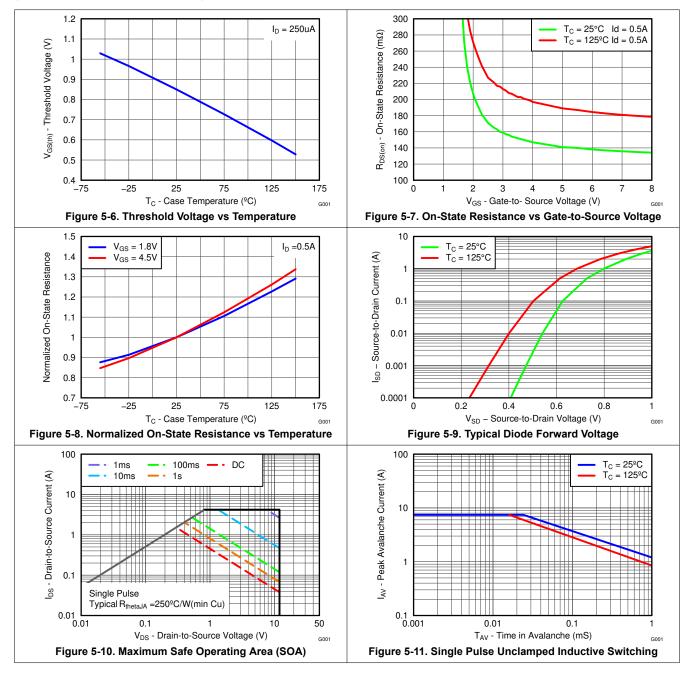
Figure 5-3. Transfer Characteristics

G001



#### **5.3 Typical MOSFET Characteristics (continued)**

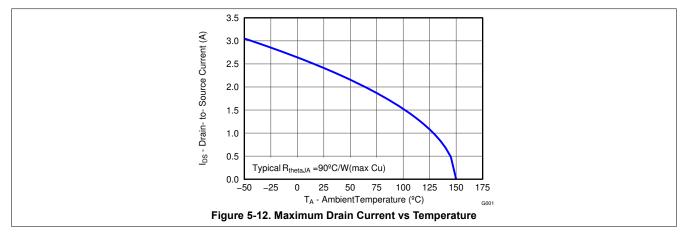
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 





## 5.3 Typical MOSFET Characteristics (continued)

(T<sub>A</sub> = 25°C unless otherwise stated)





#### 6 Device and Documentation Support

#### 6.1 Trademarks

FemtoFET<sup>™</sup> is a trademark of Texas Instruments.

is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 6.2 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 6.3 Glossary

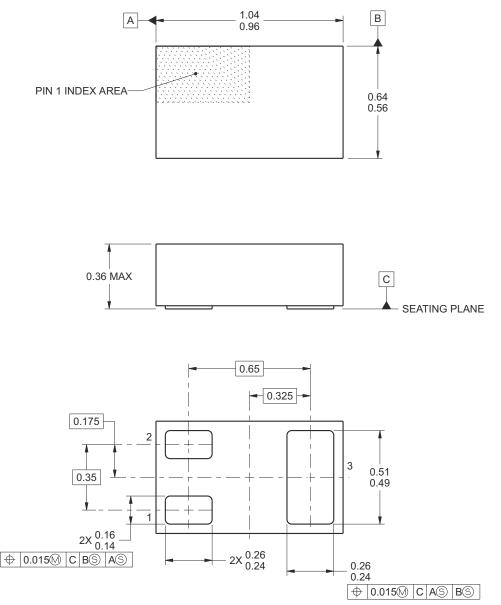
TI Glossary This glossary lists and explains terms, acronyms, and definitions.



#### 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

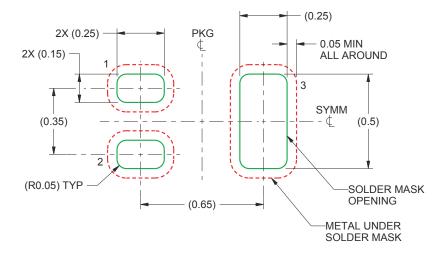
#### 7.1 Mechanical Dimensions



- A. All linear dimensions are in millimeters (dimensions and tolerancing per AME T14.5M-1994).
- B. This drawing is subject to change without notice.
- C. This package is a PB-free solder land design.



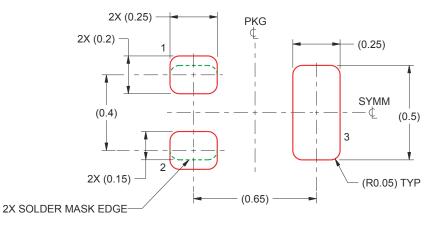
#### 7.2 Recommended Minimum PCB Layout



A. All dimensions are in millimeters.

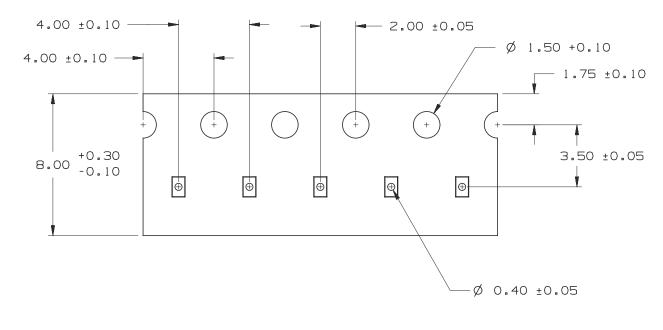
B. For more information, see FemtoFET Surface Mount Guide (SLRA003D).

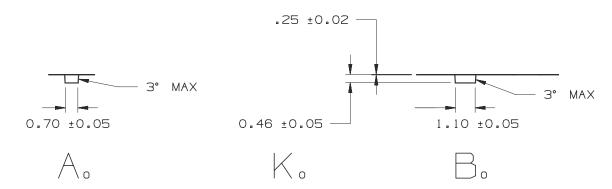
#### 7.3 Recommended Stencil Pattern



A. All dimensions are in millimeters.

### 7.4 CSD13381F4 Embossed Carrier Tape Dimensions





A. Pin 1 is oriented in the top-right quadrant of the tape enclosure (quadrant 2), closest to the carrier tape sprocket holes.



#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD13381F4	ACTIVE	PICOSTAR	YJC	3	3000	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ	Samples
CSD13381F4T	ACTIVE	PICOSTAR	YJC	3	250	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE OPTION ADDENDUM

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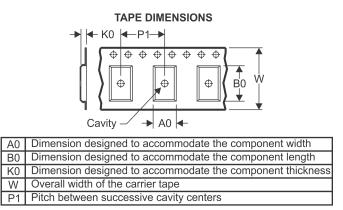
## PACKAGE MATERIALS INFORMATION

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#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD13381F4	PICOST AR	YJC	3	3000	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4	PICOST AR	YJC	3	3000	178.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4T	PICOST AR	YJC	3	250	178.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4T	PICOST AR	YJC	3	250	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2

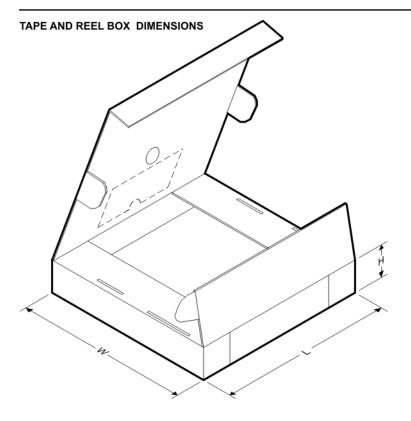
Pack Materials-Page 1



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## PACKAGE MATERIALS INFORMATION

25-Jan-2022



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD13381F4	PICOSTAR	YJC	3	3000	182.0	182.0	20.0
CSD13381F4	PICOSTAR	YJC	3	3000	220.0	220.0	35.0
CSD13381F4T	PICOSTAR	YJC	3	250	220.0	220.0	35.0
CSD13381F4T	PICOSTAR	YJC	3	250	182.0	182.0	20.0

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